

Application/Control No. 09/944,075	Applicant(s)/Patent Under Reexamination FUKUZAWA ET AL.	
Examiner Tianjie Chen	Art Unit 2652	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,962,080	10-1999	Tan et al.	427/529
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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